Inductance Investigation of $YBa_2Cu_3O_{7-\delta}$ Nano-Slit SQUIDs Fabricated With a Focused Helium Ion Beam

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Abstract—Focused helium ion beam material modification is ideally suited for the fabrication of YBa₂ Cu₃O_{7- δ} (YBCO) Josephson junctions and superconducting feature sizes down to the nanoscale. We report the fabrication and measurement of YBCO nano-slit SQUIDs and study how scaling the dimensions of the SQUID body and electrodes influences the electrical properties. Sixteen nanoslit SQUIDs with different width and length were fabricated from a single-layer 25-nm-thick YBCO film. The experimental results yield an estimation of the sheet inductance to be ~4 pH/ \Box and a penetration depth of ~180 nm. The temperature dependence of the inductance agree well with an impurity scattering model, indicating that the $T_{\rm C}$ of the film was ~82 K, and the ratio between geometric inductance and kinetic inductance at 0 K was ~0.8. These results provide solid basis for the design of high-performance, high- $T_{\rm C}$ micro-SQUID magnetometers.

Index Terms—Nano-slit SQUID, focused helium ion beam, inductance, YBCO thin film.

I. INTRODUCTION

F OCUSED helium ion beam (FHIB) materials modification is an emerging technique with the capability to make high-quality thin-film, high-transition temperature (high- $T_{\rm C}$) superconducting Josephson junctions [1]. In this method, ion irradiation converts the film from a superconductor to an insulator by disordering the crystalline lattice [2]. In contrast to other techniques to fabricate high- $T_{\rm C}$ superconducting devices based

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on grain-boundary [3], step-edge [4], or multilayer c-axis sandwich Josephson junctions [5], no material is removed or etched, as a result, nanoscale insulating features are obtainable for both Josephson junctions [6] and superconducting electrodes for devices such as superconducting quantum interference devices (SQUIDs) [7]. Scaling down to smaller junction and SQUID loop dimensions are necessary for higher integration density of superconducting circuits and for improving performance [8]. The smaller dimensions obtainable in circuit geometry afforded by scaling yields more control over circuit parameters such as critical current $I_{\rm C}$, resistance R and inductance L, the key variables for optimization of SQUIDs.

Recently, we developed a low-noise micro magnetometer based on a nano-slit SQUID using the FHIB materials modification technique to create both the junctions and the SQUID loop without any hard mask or milling process. A magnetometer was demonstrated that featured a 10 nm \times 20 μ m slit that allowed for a large inductive coupling between a $100 \times 100 \ \mu m^2$ area flux concentrating pick-up loop to the SQUID [9]. The nano-slit was instrumental in obtaining a high magnetic field sensitivity of 4 pT/Hz1/2 for such a small area sensor. This motivates a more thorough investigation into the optimization of the nanoslit geometry. Here, we further investigate nano-slit SQUID devices with a detailed investigation into the geometric variables for insight into the maximization of inductive coupling to flux concentrators. Specifically we compare the electrical transport properties of nano-slit SQUIDs with different slit dimensions (width and length) and how device performance is affected by changes in temperature.

II. EXPERIMENT

For this experiment, commercial 25 nm thick YBCO thinfilms were grown on cerium oxide buffered r-plane sapphire by reactive coevaporation. A subsequent 200 nm thick layer of gold was thermally evaporated *in-situ* for electrical contacts. Wafers were diced into 5 mm \times 5 mm chips. Substrates and large-scale electrodes were patterned into both the gold and YBCO layers using photolithography and argon ion milling. A second photolithography step and chemical etch were used to remove the gold from the area intended for FHIB direct writing, as shown in Fig. 1(a). Our test circuit layout was designed to

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Fig. 1. (a) YBCO Nano-slit SQUIDs optical photograph. (b) Zoomed in view, the red solid lines represent the light helium ion irradiation for junction writing, and the black lines represent the helium ion irradiation for nano-slit writing.

support several YBCO 4 μ m (or 8 μ m, 16 μ m) wide strip lines within a small 100 × 100 μ m² area in the center of the substrate. The close spacing of the devices was engineered to reduce errors associated with material and process non-uniformities.

Following photographic patterning, samples were loaded into an Orion Plus Helium Ion Microscope for FHIB direct write patterning using a 0.5 nm diameter, 32 keV helium ion beam. Fig. 1(b) shows an optical photograph of a sample with several YBCO strip lines, along with the FHIB irradiation patterns used to create nano-slit SQUIDs. The Josephson junctions (vertical lines) and nano-slit SQUID loop (horizontal lines) were irradiated using dosages of 8×10^{16} He +/ cm² and 8×10^{17} He + /cm² respectively.

In contrast to conventional low- $T_{\rm C}$ or high- $T_{\rm C}$ SQUIDs, the nano-slit SQUIDs have no physical hole in the material but rather an insulating region contained within a contiguous film. This innovation allows for the patterning of sub-10nm features in contrast to conventional argon ion beam etching, which degrades the superconductivity of YBCO when the feature sizes approach dimensions less than $\sim 1 \ \mu m$ [10].

We fabricated 16 nano-slit SQUID test devices in total. The width of the electrodes $w_{\rm E}$ ranges from 4 μ m to 16 μ m, while the length of the slit $l_{\rm slit}$ from 10 μ m to 70 μ m. The nano-slit SQUIDs were cooled in an evacuated dip probe with a cryoperm shield in liquid helium. Typical current-voltage characteristics (*I-V*) are shown in Fig. 2(a) for four temperatures 9 K, 24 K, 33 K, and 58 K. The paralleled Josephson junctions exhibited critical currents and resistances that ranged from 450 μ A, 265 μ A, 155 μ A to 20 μ A and 3.5 Ω , 3.3 Ω , 2.9 Ω to 2.5 Ω respectively. The resistance of these devices slightly decreased with increasing temperature for such a wide temperature range (~50 K) suggesting that the Josephson effect comes



Fig. 2. (a) The *I-V* curves of the nano-slit SQUID with 4 μ m width and 40 μ m length at 9, 24, 33, and 58K; (b) The voltage modulation of field (*V-B*) and transport current (*V-I*_{D1}) of the nano-slit SQUID measured at about 9 K.

from tunneling through an insulating barrier rather than Andrew reflection of a normal metal [6].

The SQUIDs were then statically biased just above $I_{\rm C}$ and voltage was measured as magnetic field was swept using an external coil. Typical voltages ranged from 10 μ V to 250 μ V. We remark that very large voltages are possible due to the high junction resistances obtainable with FHIB. To investigate the inductance of the YBCO thin film strip line, direct inject transport current $I_{\rm DI}$ was directly introduced into the superconducting loop of the nano-slit SQUID as illustrated in Fig. 1(b). The voltage modulation of field (*V-B*) and transport current (*V-I*_{DI}) were recorded in Fig. 2(b) at about 9 K.

III. RESULTS AND DISCUSSION

When a uniform perpendicular magnetic field *B* is applied to the nano-slit SQUIDs, the magnetic flux threading the slit per unit length Φ /l_{slit} is [11]

$$\frac{\Phi}{l_{\rm slit}} = w_{\rm E}B + \frac{\mu_0}{2\pi} \int_{-w_{\rm E}/2}^{w_{\rm E}/2} J(x) \ln \left| \frac{w_{\rm E}/2 - x}{w_{\rm E}/2 - x} \right| dx, \quad (1)$$

where $w_{\rm E}$ is the width of the electrode as illustrated in Fig. 1(b), and J(x) is the supercurrent distribution along the wide direction. Although the expression of J(x) is usually non-analytical or complicated, a uniform current distribution J(x) is a reasonable start point of discussion in the thin film limit ($t << \lambda$, where *t* is the thickness of the film and λ is the London penetration depth), especially when the $w_{\rm E}$ is comparable to $\lambda_{\rm eff} \sim \lambda^2 / t$, similar to the current distribution in the center line of a coplanar waveguide [12]. According to the model of a thin film strip line in a perpendicular field, J(x) with a uniform distribution is supposed as

$$J(x) = \begin{cases} -\frac{2B}{\mu_0}, -w_{\rm E}/2 < x < 0\\ \frac{2B}{\mu_0}, 0 < x < w_{\rm E}/2 \end{cases},$$
(2)

then we can get the integration from Eq. (1) to be

$$\Phi = w_{\rm E} l_{\rm slit} B \left(1 - \frac{2\ln 2}{\pi} \right) \approx 0.56 w_{\rm E} l_{\rm slit} B.$$
 (3)

In the limit where, $w_{\rm E} >> \lambda_{\rm eff}$, the numerical results show $\Phi \sim 0.44 w_{\rm E} l_{\rm slit} B$. We can also model it by drawing insight from similar approaches used to study flux focusing in planar junctions [13]. When a magnetic field line impinges on a superconducting thin film, it will be redirected to the nearest edges of the film in order to minimize the electromagnetic free energy. The flux in the area where the point is closer to the junction slit than other edges contributes to the total threading magnetic flux to the junction. In this manner, the total magnetic flux Φ is represented as *B* multiplied by an effective area $A_{\rm eff}$, which was theoretically and experimentally shown to be proportional to $w^2/2$, where *w* is the width of the planar junction. In this similar case, the effective area for the nano-slit SQUID from the geometry should be proportional to $\sim w_{\rm E} l_{\rm slit}/2$, as shown in Fig. 1(b).

In Fig. 3(a), we show the magnetic field periodicity ΔB determined from the *V*-*B* measurements [see Fig. 2(b)] plotted as a function of the slit length. Effective area $A_{\text{eff}} = \Phi_0/\Delta B$ was calculated and shown with a linear fit to the data. We observed that the A_{eff} of the nano-slit SQUIDs was proportional to l_{slit} and w_{E} with slope coefficients close to the value in Eq. (3). Furthermore, the nonzero y-intercept in Fig. 3(a) may be attributed to two things, first, the actual slit length which the magnetic field can go through is $l_{\text{slit}}+2\lambda_{\text{eff}}$, where λ_{eff} is ~1.3 μ m when λ ~180 nm and t ~25 nm; second, the measurement errors of the effective areas in the experiments, as shown in Fig. 3(a), the number of devices with larger length is not as many as the devices with lower length.

To investigate inductance properties, we equate the applied magnetic field periodicity with that obtained from the direct inject transport current $I_{\rm DI}$ [see Fig. 2(b)] for several devices. When a current $I_{\rm DI}$ is directly injected into the nano-slit SQUID loop, the magnetic flux coupled to the SQUID equals the product of $I_{\rm DI}$ and the inductance $L_{\rm s}$ of the path of strip line. The inductance $L_{\rm s}$, is therefore the flux quantum Φ_0 divided by $\Delta I_{\rm DI}$. In a superconducting thin film, the inductance $L_{\rm s}$ consists of geometric inductance $L_{\rm g}$ and the temperature dependent kinetic inductance $L_{\rm k}$. Again, assuming a uniform supercurrent distribution in the thin film, $L_{\rm k}$ is $\sim 2\mu_0\lambda^2 l_{\rm s}/w_{\rm E}t$, where $l_{\rm s}$ is the total length of strip line. According to a model for d-wave superconductors with impurity scattering [14], [15], the λ (T) has



Fig. 3. (a) The effective area per unit width $A_{\rm eff} / w_{\rm E}$ scaled with the slit length with fixed width 4 μ m. (b) the effective area per unit length $A_{\rm eff} / l_{\rm slit}$ scaled with the width of the nano-slit SQUID. The data were taken at about 9 K.

a temperature dependence of the form

$$\lambda\left(T\right) = \frac{\lambda\left(0\right)}{\sqrt{1 - \left(T/T_{\rm C}\right)^2}},\tag{4}$$

which yields

$$L_{\rm s} = L_{\rm g} + L_{\rm k} \left(0\right) / [1 - (T/T)^2].$$
(5)

The inductance of the strip line shared by the transport current path and the SQUID loop was extracted according to $L_s = \Phi_0/\Delta I_{\rm DI}$. The dependence between L_s and the strip line dimension yeild 4 pH/ \Box , as shown in Fig. 4(a). We built a model with the same design of those devices in the simulation tool InductEx [16], the London penetration depth is the only variable in this model, as shown in Fig. 4(b), and the value matching the experiment data the best is 180 nm, which would be used for circuit design in the future.

To further investigate the temperature dependence of the inductance, we compare measurements taken at different temperature. The direct inject current period $\Delta I_{\rm DI}$ decreased as the temperature increased implying an increase in inductance $L_{\rm s}$, as shown in Fig. 5. The results fit well with the theoretical model of the Eq. (5), and indicate that the $L_{\rm g}/L_{\rm k}(0)$ was ~0.8. By using $L_{\rm k}(0) \sim 2\mu_0\lambda(0)^2 l_{\rm s}/w_{\rm E}t$, we could deduce that the $\lambda(0)$ was ~210 nm, which in turn shows that the extracted $L_{\rm k}(0)$ is in a reasonable range.



Fig. 4. (a) The inductance L_s scaled with the length of the YBCO thin film strip line with 2 μ m width, gave an estimation of 4 pH/ \square . (b) Simulation model compared with experiment suggesting a $\lambda \sim 180$ nm.



Fig. 5. (a) The temperature dependence of the inductance of superconducting thin film stripe-line 4 μ m wide and 5 μ m long, which suggested the $T_c \sim 82$ K, $L_g/L_k(0) \sim 0.8$, and $\lambda(0) \sim 210$ nm.

IV. CONCLUSION

Nano-slit SQUIDs with different width and length were designed and fabricated by FHIB. The response to an external uniform magnetic field of these SQUIDs was explained by flux focusing effect. The inductance of the YBCO thin film strip line was thoroughly investigated. The inductance per square of our 25 nm thick YBCO thin films were estimated to be ~4 pH/ \Box , with a $\lambda(0) \sim 180$ nm. The temperature dependence of the inductance of YBCO thin film was explained by a theoretical model for a d-wave superconductor, and the fittings gave an estimation of $L_g/L_k(0) \sim 0.8$. These results provide a wealth of knowledge into the optimization and the design of future devices. The much improved sensitivity over similarly sized prior-art devices [17] suggest a new nano-slit approach to compact multi SQUID arrays [18].

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